

Search Notes



Application/Control No.

10/694,113

Examiner

Russell Frejd

Applicant(s)/Patent under Reexamination

CHENG, WAI BIU

Art Unit

2128

SEARCHED

Class	Subclass	Date	Examiner
703	2, 4	3.4.06	RF
	12, 22		
700	266		
	270		
	273		
203	1, 3		
210	640		
706	45		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
703	6, 22	3.18.06	RF
203	1		
700	270		
5	273		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
IEEE Xplore	3.4.06	RF
INSPIC DIALOG		
ACM DIGITAL LIB		
SCIENCE DIRECT		
PROQUEST		
WEST		